

## INFORMATION CITED BY APPLICANT THAT MAY BE MATERIAL TO THE PROSECUTION OF THE SUBJECT APPLICATION

Applicant:

M. Feldman

Attorney Docket No. MEIP122467

Application No.: 10/814,755

Group Art Unit: 2877

Filed:

March 31, 2004

Title:

IMPROVED WAVELENGTH DETECTOR

## **U.S. PATENT DOCUMENTS**

*Examiner	r Cite No.	Document No.	Kind Code	Date (mm/dd/yyyy)	Name
PC	_ U1	4,308,456	Α	12/29/1981	Van Der Gaag et al.
PC	_ U2	5,627,648	Α	05/06/1997	Garrett
PC	_ U3	5,729,347	Α	03/17/1998	So
PC	_ U4	2002/0126288	A1	09/12/2002	Friberg et al.

## **FOREIGN PATENT DOCUMENTS**

*Examiner Cite			w:	Publication Date		English	
						Abstract	Translation
Initial	No.	Document No.	Code	(mm/dd/yyyy)	Country	Provided	Provided

None

## **OTHER INFORMATION** (Including Author, Title, Date, Pertinent Pages, Etc.)

*Examiner	Cite		
Initial	No.		

None

Examiner

**Date Considered** 

/Patrick Connolly/ (08/29/2006)

\*Examiner: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

SIL:vas

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